

Notice of References Cited	Application/Control No. 10/785,182	Applicant(s)/Patent Under Reexamination WANG ET AL.	
	Examiner Anabel M. Ton	Art Unit 2875	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2005/0036296	02-2005	Kim et al.	362/031
	C	US-2004/0228110	11-2004	Hsieh et al.	362/031
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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